


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/773,554	WU ET AL.	
	Examiner	Art Unit	
	Hai L. Nguyen	2816	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS	SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
327	172				327	175	100			
INTERNATIONAL CLASSIFICATION										
H	0	3	K	3/017						
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Hai L. Nguyen (Assistant Examiner)	03/14/2005 (Date)	<i>Kenneth B. Wells</i> Kenneth B. Wells Primary Examiner (Primary Examiner)	<i>3/18/05</i> (Date)	Total Claims Allowed: 21	
<i>Amelia Smith</i> (Legal Instruments Examiner)	<i>3/2/05</i> (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 3 & 5A

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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